

**Search Notes**

Application/Control No.

10/689,950

Examiner

Nhan T. Tran

Applicant(s)/Patent under  
Reexamination

HIGURASHI ET AL.

Art Unit

2622

**SEARCHED**

Class	Subclass	Date	Examiner
348	208.3	3/8/2007	NT
396	55	3/13/2007	NT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search (USPAT, PGPUB, JPO, EPO, DERWENT, IBM_TDB)	3/8/2007	NT
348/208.1-208.16, 208.99 (text search - see search history printout)	3/8/2007	NT
348/240.1-240.3 (text search - see search history printout)	3/9/2007	NT